

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination	
			10/710,345	CHOU, PIN-HUNG	
Examiner			Art Unit		
Dameon E. Levi			2841	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,774,872	08-2004	Kawada et al.	345/60
*	B	US-5,777,610	07-1998	Sugimoto et al.	345/206
*	C	US-5,606,440	02-1997	Kawaguchi et al.	349/188
*	D	US-5,822,191	10-1998	Tagusa et al.	361/751
*	E	US-6,813,159	11-2004	Irie et al.	361/752
*	F	US-6,560,124	05-2003	Irie et al.	361/816
*	G	US-6,677,664	01-2004	Inoue et al.	257/668
*	H	US-6,703,702	03-2004	Inoue et al.	257/684
*	I	US-6,104,464	08-2000	Adachi et al.	349/150
*	J	US-6,342,932	01-2002	Terao et al.	349/58
*	K	US-6,534,722	03-2003	Takaoka, Takuya	174/254
*	L	US-6,825,894	11-2004	Aoyagi et al.	349/61
*	M	US-6,903,794	06-2005	Fukuta et al.	349/150

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.